

STD95N4LF3

N-channel 40 V, 5.0 mΩtyp., 80 A STripFET™ III Power MOSFET in a DPAK package

Datasheet — production data

Features

Туре	V _{DSS}	V _{DSS} R _{DS(on)} max		P _D
STD95N4LF3	40 V	$<$ 6.0 m Ω	80 A ⁽¹⁾	110 W

- 1. Value limited by wire bonding
- 100% avalanche tested
- Logic level drive

Applications

- Switching application
 - Automotive



This device is an N-channel enhancement mode Power MOSFET produced using STMicroelectronics' STripFET™ III technology, which is specifically designed to minimize onresistance and gate charge to provide superior switching performance.

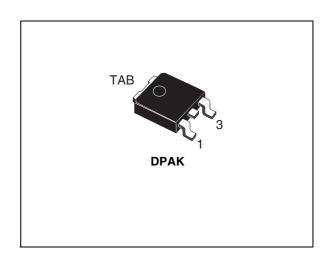


Figure 1. Internal schematic diagram

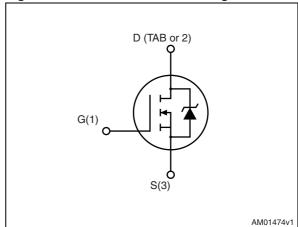


Table 1. Device summary

Order codes	Marking	Package	Packaging
STD95N4LF3	95N4LF3	DPAK	Tape and reel

Contents STD95N4LF3

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STD95N4LF3 Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage	40	V
V _{GS}	Gate-source voltage	± 16	V
I _D ⁽¹⁾	Drain current (continuous) at T _C = 25 °C	80	Α
I _D	Drain current (continuous) at T _C = 100 °C	65	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	320	Α
P _{TOT}	Total dissipation at T _C = 25 °C	110	W
	Derating factor	0.73	W/°C
dv/dt (3)	Peak diode recovery voltage slope	8	V/ns
E _{AS} (4)	Single pulse avalanche energy	400	mJ
T _j T _{stg}	Operating junction temperature Storage temperature	-55 to 175	°C

^{1.} Value limited by wire bonding

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	1.36	°C/W
R _{thj-pcb} (1)	Thermal resistance junction-pcb max	50	°C/W

^{1.} When mounted on 1inch² FR-4 2Oz Cu board

^{2.} Pulse width limited by safe operating area

^{3.} $I_{SD}~\leq 80~A,~di/dt~\leq 40~A/\mu s,~V_{DS}~\leq~V_{(BR)DSS},~T_{J}~\leq~T_{JMAX}$

^{4.} Starting T_J = 25 °C, I_D = 40 A, V_{DD} = 35 V *Figure 16* and *Figure 17*

Electrical characteristics STD95N4LF3

2 Electrical characteristics

 $(T_{CASE} = 25 \, ^{\circ}C \text{ unless otherwise specified})$

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 250 \mu A, V_{GS} = 0$	40			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = 40 V V _{DS} = 40 V, T _C = 125 °C			10 100	μ Α μ Α
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 16 V			±200	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1		2.5	V
R _{DS(on)}	Static drain-source on- resistance	$V_{GS} = 10 \text{ V}, I_D = 40 \text{ A}$ $V_{GS} = 5 \text{ V}, I_D = 40 \text{ A}$		5.0	6.0 9.0	mΩ

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25 \text{ V, f} = 1 \text{ MHz,}$ $V_{GS} = 0$	-	2500 560 50		pF pF pF
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD} = 20 V, I_D = 40 A R_G = 4.7 ΩV_{GS} = 10 V (see <i>Figure 13</i> and <i>Figure 18</i>)	-	7.5 45 45 11		ns ns ns
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V _{DD} = 20 V, I _D = 80 A, V _{GS} = 10 V (see <i>Figure 14</i>)	-	50 7 9.5	70	nC nC nC

Table 6. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current Source-drain current (pulsed)		-		80 320	A A
V _{SD} (2)	Forward on voltage	I _{SD} = 80 A, V _{GS} = 0	-		1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} = 80 A, di/dt = 100 A/µs, V_{DD} = 20 V, T_j = 150 °C (see <i>Figure 15</i> and <i>Figure 19</i>)	-	40 55 3		ns nC A

^{1.} Pulse width limited by safe operating area.

^{2.} Pulsed: Pulse duration = $300 \mu s$, duty cycle 1.5%

Electrical characteristics STD95N4LF3

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance

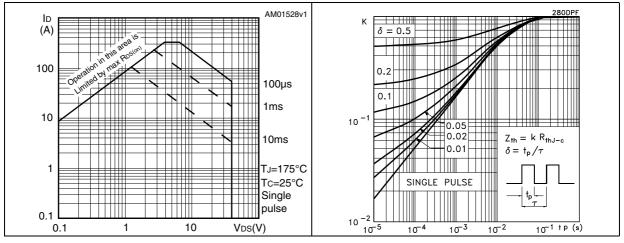


Figure 4. Output characteristics

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Figure 5. Transfer characteristics

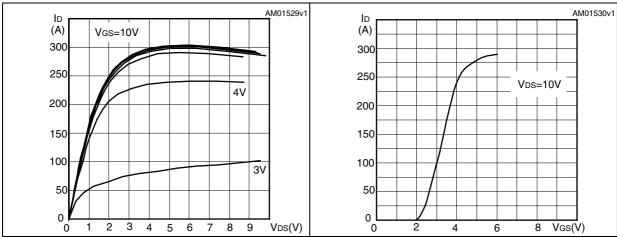
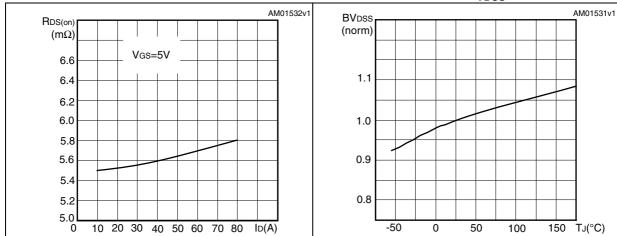


Figure 6. Static drain-source on-resistance $\,$ Figure 7. Normalized $\,$ BVDSS $\,$ VS temperature



AM01533v1 AM01534v1 Vgs С (pF) (V) VDD=20V 12 f=1MHz 5000 Vgs=10V VDS=25V 4500 ID=80A Vgs=0 10 4000 3500 8 3000 Ciss 6 2500 2000 1500 1000 2 Coss 500 Crss 20 10 30 40 50 Qg(nC) 5 10 15 20 25 30 35 VDS(V) 0 0

Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

Figure 10. Normalized gate threshold voltage Figure 11. Normalized on resistance vs vs temperature temperature

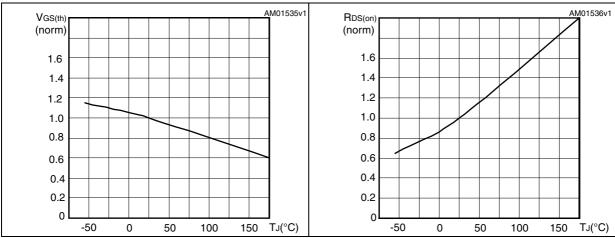
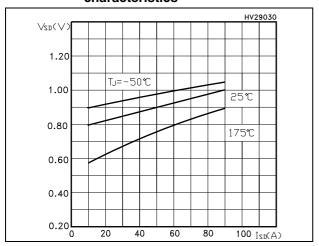


Figure 12. Source-drain diode forward characteristics



Test circuits STD95N4LF3

3 Test circuits

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

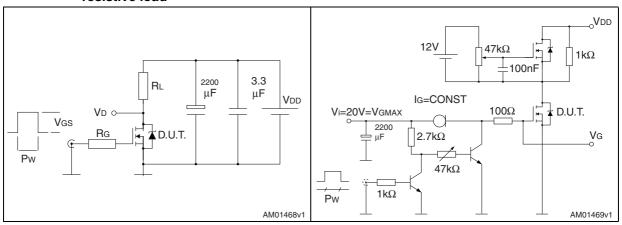


Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped inductive load test circuit

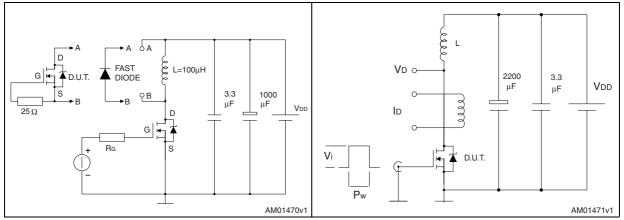
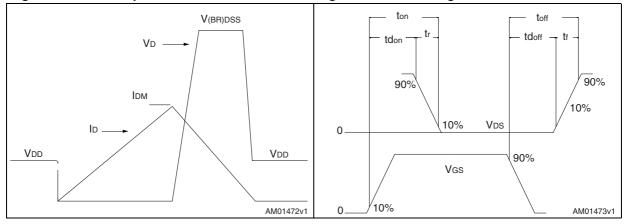


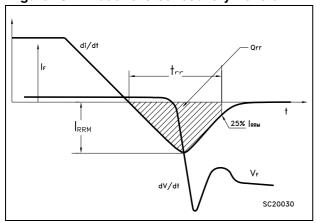
Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



STD95N4LF3 Test circuits

Figure 19. Diode reverse recovery waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Table 7. DPAK (TO-252) mechanical data

Dim.		mm	
Dim.	Min.	Тур.	Max.
Α	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
С	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1		5.10	
Е	6.40		6.60
E1		4.70	
е		2.28	
e1	4.40		4.60
Н	9.35		10.10
L	1		
L1		2.80	
L2		0.80	
L4	0.60		1
R		0.20	
V2	0°		8°

Figure 20. DPAK (TO-252) drawing

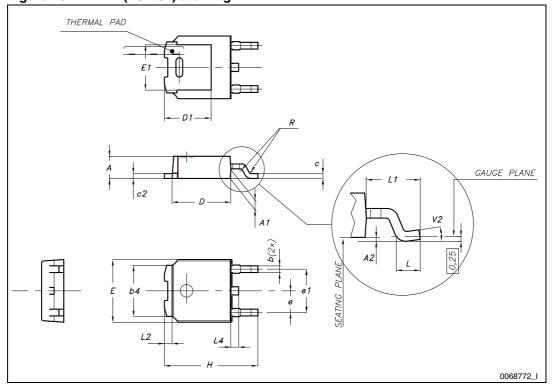
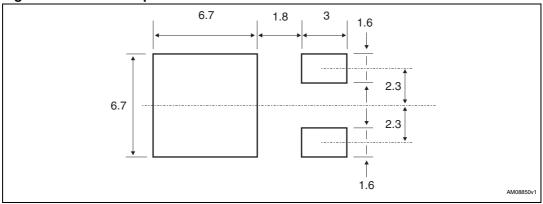


Figure 21. DPAK footprint^(a)



577

a. All dimensions are in millimeters

5 Packing mechanical data

Table 8. DPAK (TO-252) tape and reel mechanical data

abic o.	Tape	oz) tape and reer		Reel	
Di-		nm	Dim		ım
Dim.	Min.	Max.	— Dim.	Min.	Max.
A0	6.8	7	Α		330
В0	10.4	10.6	В	1.5	
B1		12.1	С	12.8	13.2
D	1.5	1.6	D	20.2	
D1	1.5		G	16.4	18.4
Е	1.65	1.85	N	50	
F	7.4	7.6	Т		22.4
K0	2.55	2.75			
P0	3.9	4.1		Base qty.	2500
P1	7.9	8.1		Bulk qty.	2500
P2	1.9	2.1			•
R	40				
Т	0.25	0.35			
W	15.7	16.3			

Figure 22. Tape for DPAK (TO-252)

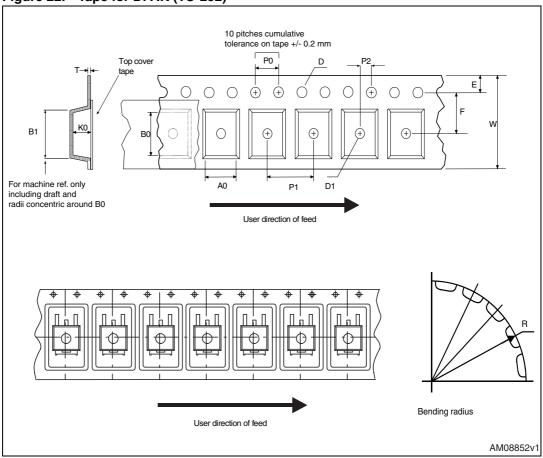
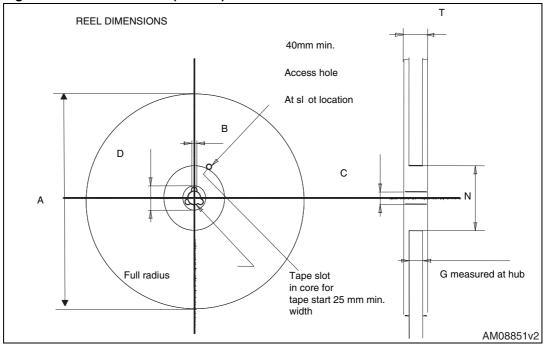


Figure 23. Reel for DPAK (TO-252)



Revision history STD95N4LF3

6 Revision history

Table 9. Document revision history

Date	Revision	Changes
11-Feb-2009	1	First release
23-Jul-2009	2	Marking on device summary has been corrected.
13-Jul-2012	3	Updated title on the cover page. Minor text changes. Updated Section 4: Package mechanical data and Section 5: Packing mechanical data.

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